

Notice of References Cited	Application/Control No. 10/670,223	Applicant(s)/Patent Under Reexamination WAKAYAMA, HIDESHI	
	Examiner Rodney H. Bonck	Art Unit 3681	Page 1 of 1

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	M	US-			

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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